Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination OSHIMA ET AL.	
10/656,507		
Examiner	Art Unit	
Christopher A. Revak	2131	

SEARCHED					
Class	Subclass	Date	Examiner		
713	200,201	6/28/2005	CR		
709	217-219	6/28/2005	CR		
709	223,224	6/28/2005	CR		
707	1,9,10	6/28/2005	CR		
707	200-204	6/28/2005	CR		
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